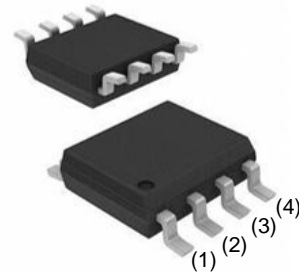
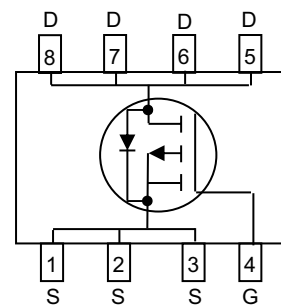


**WPM3021**

Single P-Channel, -30V, -11.5A, Power MOSFET

[Http://www.sh-willsemi.com](http://www.sh-willsemi.com)

V <sub>DS</sub> (V)	Typical R <sub>DS(on)</sub> (mΩ)
-30	11 @ V <sub>GS</sub> =-10V
	15 @ V <sub>GS</sub> =-5V


**SOP-8L**

**Pin configuration (Top view)**
**Descriptions**

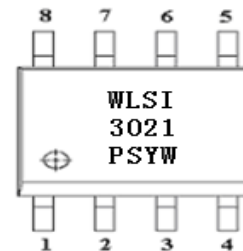
The WPM3021 is P-Channel enhancement MOS Field Effect Transistor. Uses advanced trench technology and design to provide excellent R<sub>DS(ON)</sub> with low gate charge. This device is suitable for use in DC-DC conversion, power switch and charging circuit. Standard Product WPM3021 is Pb-free.

**Features**

- Trench Technology
- Supper high density cell design
- Excellent ON resistance
- Extremely Low Threshold Voltage
- Small package SOP-8L

**Applications**

- DC/DC converters
- Power supply converters circuit
- Load/Power Switching for portable device



PS =DeviceCode  
 Y =Year  
 W =Week(A~z)

**Marking**
**Order information**

Device	Package	Shipping
WPM3021-8/TR	SOP-8L	2500/Tape&Reel

**Absolute Maximum ratings**

Parameter	Symbol	10 s	Steady State	Unit	
Drain-Source Voltage	$V_{DS}$	-30		V	
Gate-Source Voltage	$V_{GS}$	±25			
Continuous Drain Current <sup>a d</sup>	$I_D$	$T_A=25^{\circ}C$	-11.5	-8.8	A
		$T_A=70^{\circ}C$	-9.4	-7.0	
Maximum Power Dissipation <sup>a d</sup>	$P_D$	$T_A=25^{\circ}C$	3.0	1.7	W
		$T_A=70^{\circ}C$	1.9	1.1	
Continuous Drain Current <sup>b d</sup>	$I_D$	$T_A=25^{\circ}C$	-8.4	-6.8	A
		$T_A=70^{\circ}C$	-6.7	-5.4	
Maximum Power Dissipation <sup>b d</sup>	$P_D$	$T_A=25^{\circ}C$	1.5	1.0	W
		$T_A=70^{\circ}C$	1.0	0.6	
Pulsed Drain Current <sup>c</sup>	$I_{DM}$	-47		A	
Operating Junction Temperature	$T_J$	-55 to 150		°C	
Lead Temperature	$T_L$	260		°C	
Storage Temperature Range	$T_{stg}$	-55 to 150		°C	

**Thermal resistance ratings**

Single Operation					
Parameter		Symbol	Typical	Maximum	Unit
Junction-to-Ambient Thermal Resistance <sup>a</sup>	$t \leq 10$ s	$R_{\theta JA}$	32	42	°C/W
	Steady State		59	75	
Junction-to-Ambient Thermal Resistance <sup>b</sup>	$t \leq 10$ s	$R_{\theta JA}$	59	81	
	Steady State		95	125	
Junction-to-Case Thermal Resistance	Steady State	$R_{\theta JC}$	35	45	

a Surface mounted on FR4 Board using 1 square inch pad size, 2oz copper

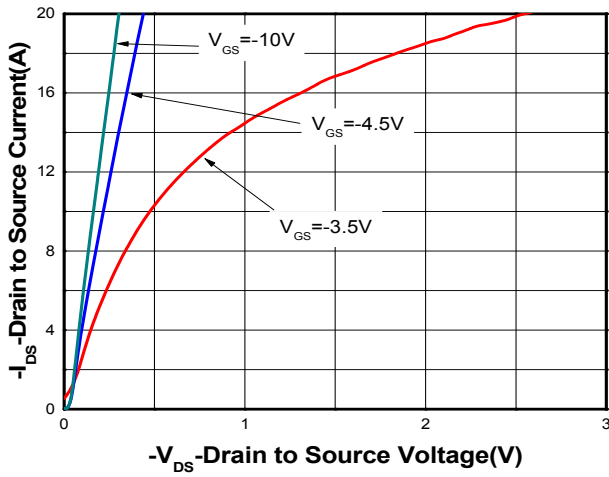
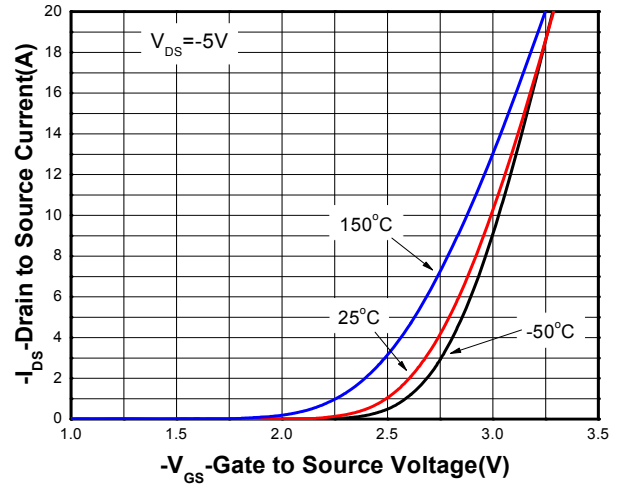
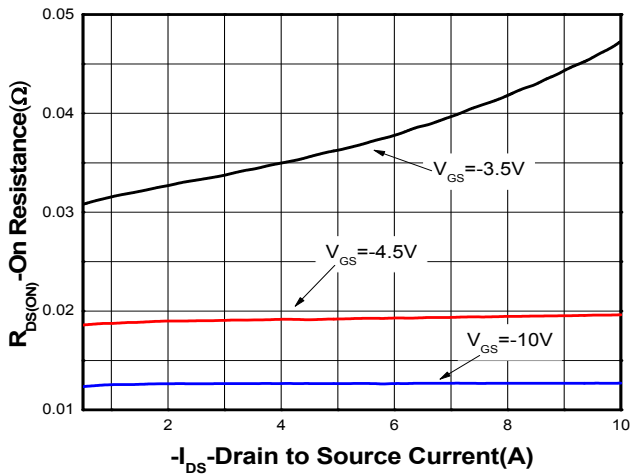
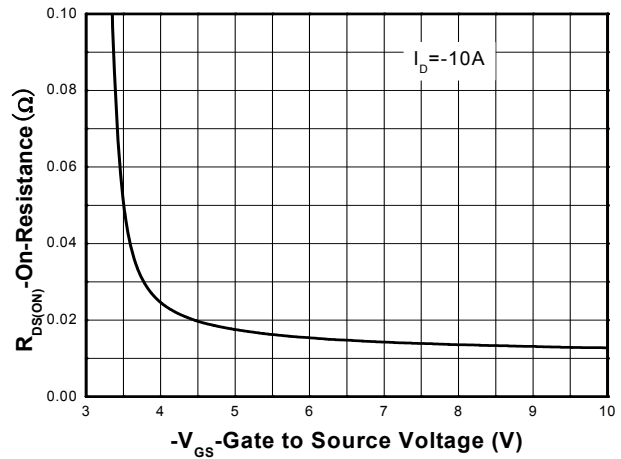
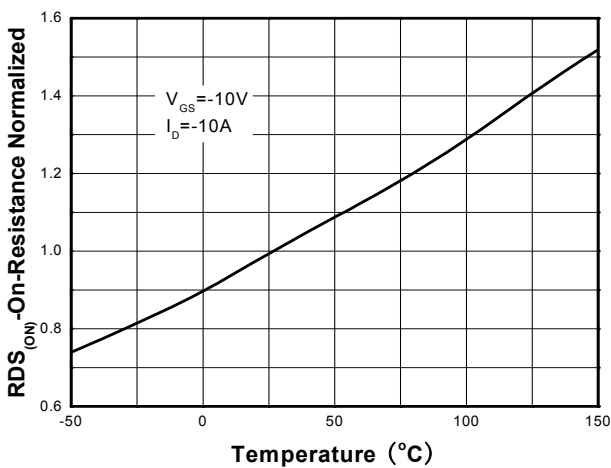
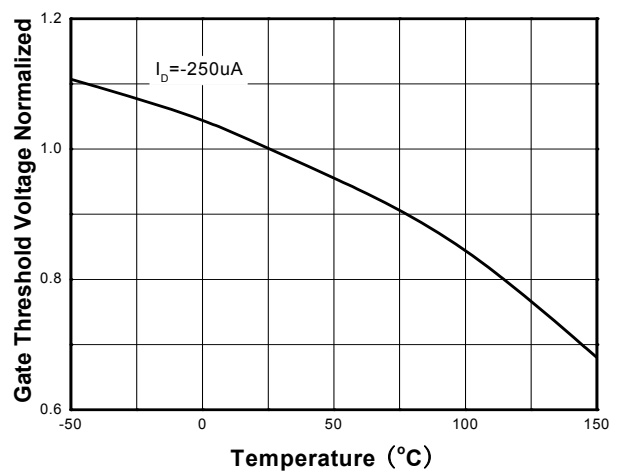
b Surface mounted on FR4 board using minimum pad size, 2oz copper

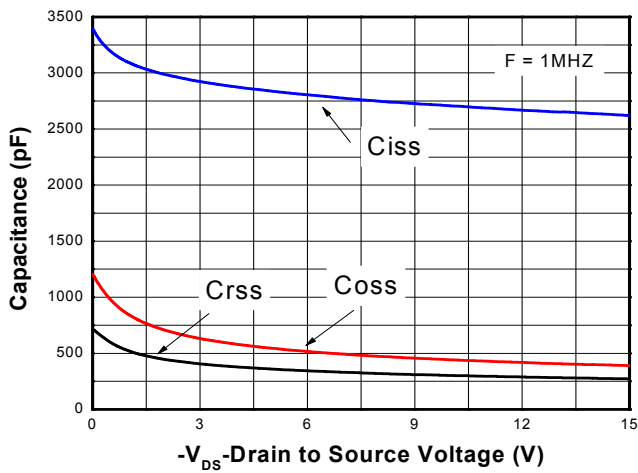
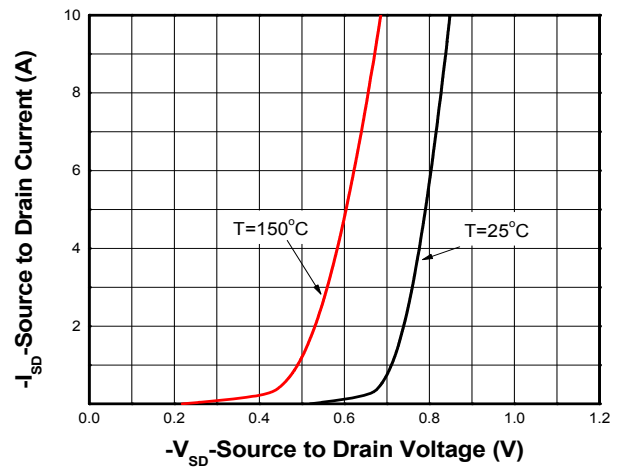
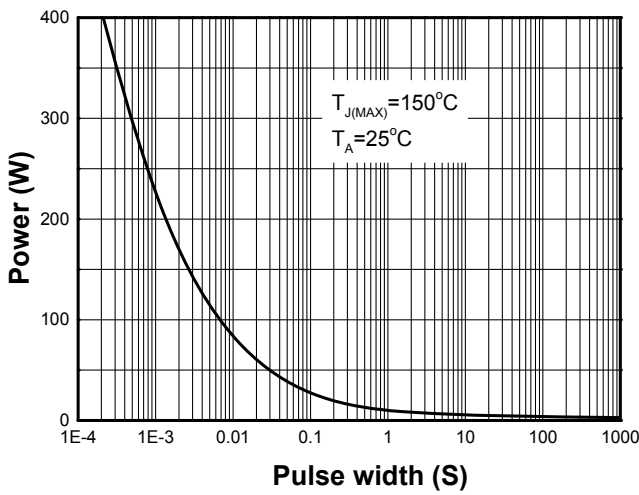
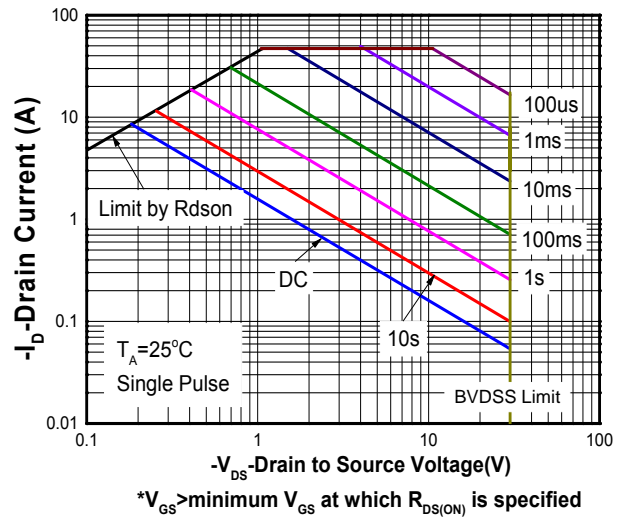
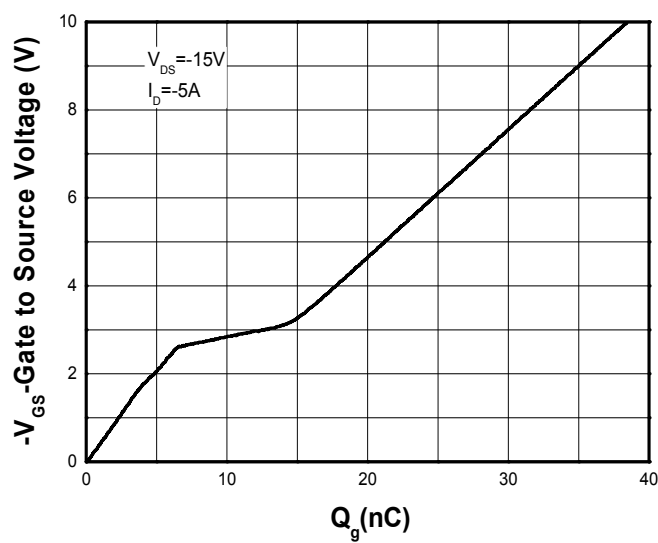
c Repetitive rating, pulse width limited by junction temperature,  $t_p=10\mu s$ , Duty Cycle=1%

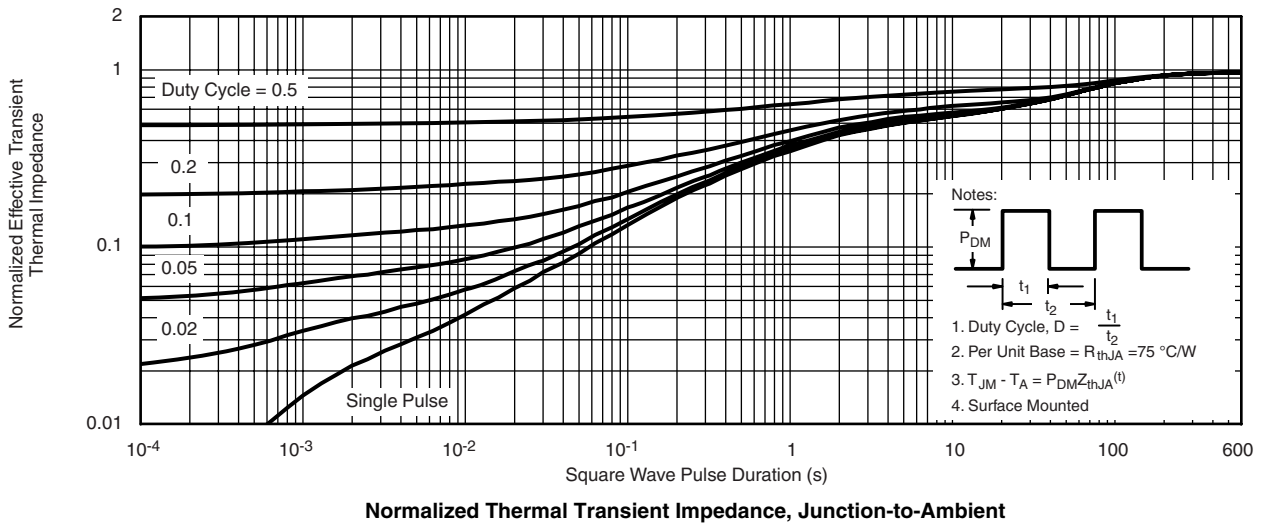
d Repetitive rating, pulse width limited by junction temperature  $T_J=150^{\circ}C$ .

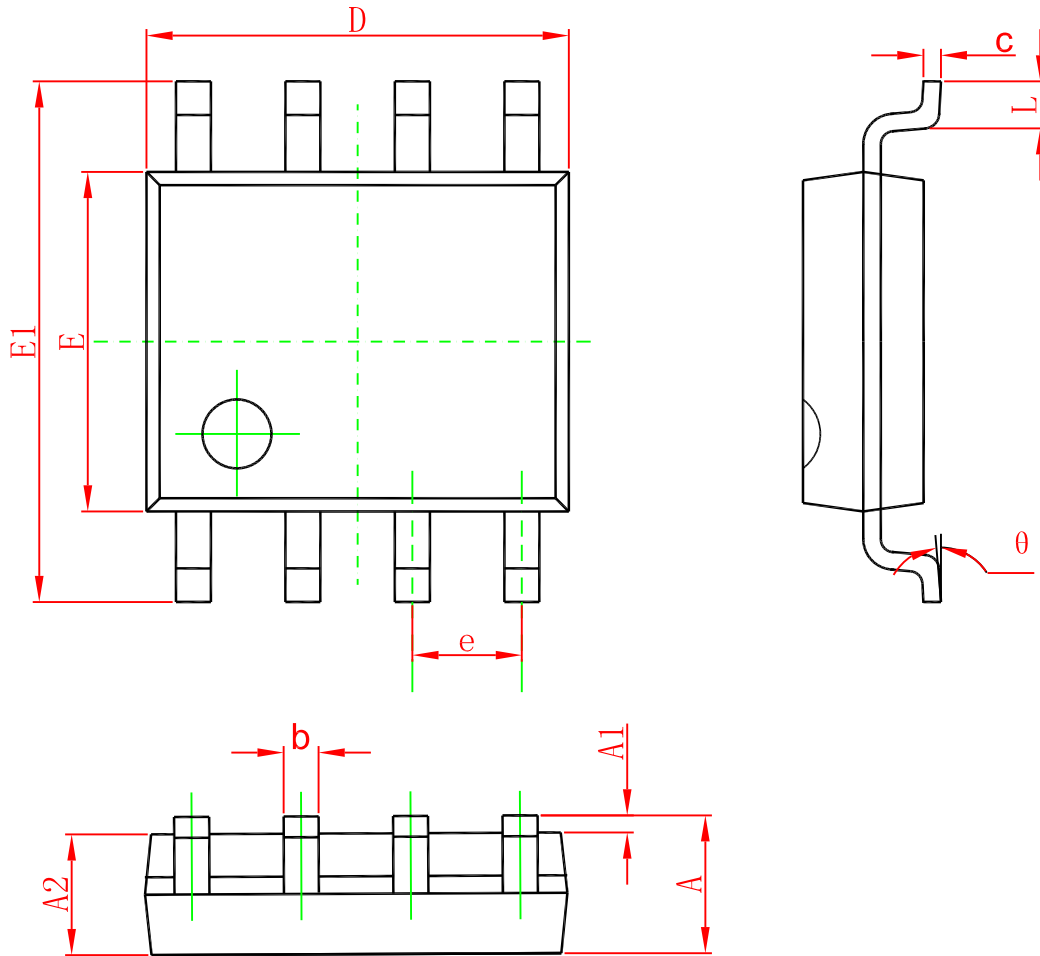
**Electronics Characteristics (Ta=25°C, unless otherwise noted)**

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
<b>OFF CHARACTERISTICS</b>						
Drain-to-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS} = 0\text{ V}, I_D = -250\mu\text{A}$	-30			V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = -24\text{ V}, V_{GS} = 0\text{ V}$			-1	$\mu\text{A}$
Gate-to-source Leakage Current	$I_{GSS}$	$V_{DS} = 0\text{ V}, V_{GS} = \pm 25\text{ V}$			$\pm 1$	$\mu\text{A}$
<b>ON CHARACTERISTICS</b>						
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = -250\mu\text{A}$	-1.0	-1.8	-3.0	V
Drain-to-source On-resistance	$R_{DS(on)}$	$V_{GS} = -10\text{ V}, I_D = -10\text{ A}$		11	15	m $\Omega$
		$V_{GS} = -5\text{ V}, I_D = -7\text{ A}$		15	20	
Forward Transconductance	$g_{FS}$	$V_{DS} = -5\text{ V}, I_D = -8\text{ A}$		7	16	S
<b>CHARGES, CAPACITANCES AND GATE RESISTANCE</b>						
Input Capacitance	$C_{ISS}$	$V_{GS} = 0\text{ V}, f = 1.0\text{ MHz}, V_{DS} = -15\text{ V}$		2800		pF
Output Capacitance	$C_{OSS}$			435		
Reverse Transfer Capacitance	$C_{RSS}$			330		
Total Gate Charge	$Q_{G(TOT)}$	$V_{GS} = -10\text{ V}, V_{DS} = -15\text{ V}, I_D = -10\text{ A}$		39		nC
Threshold Gate Charge	$Q_{G(TH)}$			6		
Gate-to-Source Charge	$Q_{GS}$			8		
Gate-to-Drain Charge	$Q_{GD}$			7		
<b>SWITCHING CHARACTERISTICS</b>						
Turn-On Delay Time	$t_d(ON)$	$V_{GS} = -10\text{ V}, V_{DS} = -15\text{ V}, I_D = -5\text{ A}, R_G = 6\Omega$		19		ns
Rise Time	$t_r$			12		
Turn-Off Delay Time	$t_d(OFF)$			110		
Fall Time	$t_f$			32		
<b>BODY DIODE CHARACTERISTICS</b>						
Forward Voltage	$V_{SD}$	$V_{GS} = 0\text{ V}, I_S = -1\text{ A}$	-0.5	-0.8	-1.2	V

**Typical Characteristics (Ta=25°C, unless otherwise noted)**

**Output characteristics**

**Transfer characteristics**

**On-Resistance vs. Drain current**

**On-Resistance vs. Gate-to-source voltage**

**On-Resistance vs. Junction temperature**

**Threshold voltage vs. Temperature**


**Capacitance**

**Body diode forward voltage**

**Single pulse power**

**Safe operating power**

**Gate Charge Characteristics**



**Package outline dimensions**
**SOP-8L**


Symbol	Dimensions in millimeter		
	Min.	Typ.	Max.
A	1.350	1.550	1.750
A1	0.100	0.150	0.250
A2	1.250	1.400	1.650
b	0.380	-	0.510
c	0.170	-	0.250
D	4.800	4.900	5.000
E	3.800	3.900	4.000
E1	5.800	6.000	6.200
e	1.270(BSC)		
L	0.450	0.600	0.800
θ	0°	-	8°